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### HOWARD UNIVERSITY

DEPARTMENT OF CHEMISTRY

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## THIRD QUARTERLY REPORT 1 October 1963 to 1 January 1964

## MICROWAVE SPECTRA AND DIELECTRIC PROPERTIES OF VARIOUS AZIDES

Contract DA-44-009-AMC-217I

U. S. Army Engineer Research and Development Laboratories

Fort Belvoir, Virginia

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Submitted by:

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Eccession No.  Eccession No.  Eccession No.  Licroweve Spectra and Dielectric Properties of Various Azides. Project No. 8X99-25-001-41  C. P. Carter and G. C. Turnell  Contract Di-44-009-AMC-217(T)  Third Quarterly Rext 1 Oct 63 to 1 Jan 64  13 pp 3 Tables Unclassified Rept The dielectric constant of lead azide has been measured in the frequency range 39-49 Kmc.  For \$\beta\$-lead azide the real part of the dielectric constant tends to increase with increasing frequency, ranging from about 11 at 39 Kmc to 15 at 49 Kmc. The imaginary part of the dielectric constant shows no clear trend in this frequency range, where its average value is approximately 0.33.	Howard University, Washington, D. C.  Microwave Spectra and Dielectric Properties of Various Azides. Project No. 8X99-25-001-41  C. P. Carter and G. C. Turrell  Contract DA-44-009-AMC-217(T)  Third Quarterly Rept  1 Oct 63 to 1 Jan 64  13 pp  3 Tables  Unclassified Rept The dielectric constant of lead azide has been measured in the frequency range 39-49 Kmc.  For 9-lead azide the real part of the dielectric constant tends to increase with increasing frequency, ranging from about 11 at 39 Kmc to 15 at 49 Kmc. The imaginary part of the dielectric constant shows no clear trend in this frequency range, where its average value is approximately
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Approximate Accession No.  Howard University, Washington, D. C.  Microwav Syceiru and Dielectric Preparites of Various Azides, Project No. SNS3-25-501-21 C. P. Cartor and G. C. Turrell Confract DA-44-099-AliC-217(T) Third Quarterly Rept 1 Oct 63 to 1 Jan 64 13 pp 3 Tables Unclassified Rept The dielectric constant of Icad azide has been measured in the frequency range 35-48 kms. For 9-1cad azide the real part of the dielectric constant tends to increase with increasing frequency, ranging from about 11 at 39 kms to 15 at 49 kmc. The imaginary part of the dielectric constant shows no clear trend in this frequency range, where its average value is approximately 0.33.	Accession No.  Howard University, Washington, D. C.  Microwave Spectra and Dielectric Projecties of Various Azides. Project No. 8X99-25-001-41  C. P. Carter and G. C. Turrell  Contract DA-44-009-AMC-217(T)  Third Quarterly Rept  1 Oct 63 to 1 Jan 64  13 pp  3 Tables  Unclassified Rept The dielectric constant of lead azide has been measured in the frequency range 39-49 Kmc.  For \(\beta\)-lead azide the real part of the dielectric constant tends to increase with increasing frequency, ranging from about 11 at 39 Kmc to 15 at 49 Kmc. The imaginary part of the dielectric constant shows no clear trend in this frequency range, where its average value is approximately 0.33.

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#### Dielectric Constants of the Lead Azides

### INTRODUCTION

In a previous report dotails were given of the method used for measuring the shift in the resonance frequency of a cavity due to the introduction of a small rod of a dielectric material. It was shown how this frequency shift is related to the real part of the dielectric constant of the material.

The method of determining the change in the Q's of the cavity and the relationship between these and the imminary dielectric constant of the material were also quantitatively given. Experimental data were presented on one sample of polystyrene and one sample of load azide in the frequency range 39-42 kmc. The precision of the data was discussed in the case in which the same sample is used throughout a series of measurements.

In this report the data have been extended to include several samples of polystyrene and lead azide in the frequency range 39-49 kmc. These results indicate the effect of sample shape and irregularity on the precision of the results. It is shown that such factors as (1) the irregular shape of the crystals, (2) the fact that the ends of the sample are not exactly at nodes in the field at all frequencies, (3) the very large number of crystal defects present, etc., have effects on the values of the dielectric constant determined by the present technique.

### II. EXPERIMENTAL

Heasurements were made on five samples of polystyrene in the frequency range 39-42 kmc. One sample of  $\mathcal{L}$ —lead azide and four samples of  $\beta$ —lead azide and four samples of  $\beta$ —lead azide were studied in the frequency range 39-49 kmc. These azide samples were of various sizes. The masses ranged from 0.05 mg to 1.3 mg with corresponding volumes of 1.0 kmc<sup>-5</sup> to 2.7 x 10<sup>-3</sup> cm<sup>3</sup>. The volumes were calculated using the literature density values as determined by x-ray diffraction and the sample weight. This fact is mentioned because the method does not take into account the presence of crystal defects.

All measurements were taken as described in an earlier report Each entry represents an average of ten measurements. The  $TH_{012}$  mode was used throughout and the width of the resonance curve,  $\Delta f_1$ , was taken at -7.0 db for the Q measurements in all cases.

First a ripple in the klystren power supply, causing an unsteady r-f output, foreclosed every attempt at attaining meaningful data.

This was followed by trouble with the spectrum analyzer used to put marker on the oscilloscope trace of power versus frequency. In each of these cases unsuccessful attempts were made to correct the malfunctions in this laboratory. Assistance was obtained from the Electronics Service Section of ERDL at Fort Belvoir but the malfunctions could not be isolated and corrected. Finally the power source unit and the spectrum smalyzer were returned to the manufacturer, Polerad, Inc., in New York. After complete overhaul, these instruments are now

functioning properly.

Considerable time and effort were expended in attempts to design and build a shutter which would facilitate and accelerate the Q-measurements. A drawing of one design was shown in one of the carlier reports. Design of such a shutter for a single frequency would not present major difficulties; but a shutter to cover a wide range of frequencies presents problems which, as yet, we have not solved. In every autompt which we have made, either the loss at the shutter was too large or data were not reproducible. While it is thought that the design of such a shutter is quite feasible, it was considered inadvisable to expend more time in this direction at this time.

### III. PABULATION OF DATA

The observed data are recorded in tables I-V. In table I are recorded all data necessary for calculation of the real dielectric constant of lead axide. The values of the real dielectric constant to calculated from this data are recorded in table II. The corresponding data for polystyrone are recorded in tables III and V.

TABLE I Summary of Observed Bata for Calculation of

Som J.	Tane	Weight	Volume				F.	Frequency (X)	(xMc) + f			
#		of Sample (mg)	_	39.46	1 20,30 1 41.40	1 1 1	- 42.20 ्रेट्ट			06.97	77.90	9.87
ri	र्	1,273	2.674 x10-3	711	127	125	114					<u> </u>
7	e,	0.1728	3.5.20 x10 <sup>-5</sup>	22.4	22.8	23.7	19.1	25.4	26.0	26.2	26.7	27.5
3	1.7	8970°0	9°23 x10_6	6*4	8*3	7.5	6.8	9.1	9.6	6.6	10.6	11.5
7	* 1° 1	0,0580	1.181 x10 <sup>-5</sup>	10.0	10.4	6.01	12.5		13.8	15.8		
5	( g	8280.0	3.808 x10 <sup>-5</sup>	30.6	31.0	31.5	32.9	35.4	37.7	43.6	45.5	47.1
		Cavity Volume on?	une cm <sup>3</sup>	0.4697	0,4531	0.4344	0.4128	0.3862	0.3794	0.3639	0,3588	0,3516
•	- T-T-T-T-T-T-T-T-T-T-T-T-T-T-T-T-T-T-T	G I	<b>~</b>	0.950	176*0	078*0	0.831	0.734	0.702	0.693	0.645	0.627
н		بالموادد		1.795x10	1.795x103 1.694x103 1.624103 1.544x103	3 1.624103	1.544×10					
ኢ		<b>→</b> •••		1.334×10	1.287×10	1.23404	1.173×104	401×160-4	1.079x104	p.034×104	1.334x104 1.287x104 1.23404 1.173x104 1.097x104 1.079x104 1.034x104 1.619x104 10.999 x104	10.999 x104
3	-	· · · · · · · ·		4.930x10	4.750:10	4.56904	4.3302104	4.052×104	\$-981×104	3.513.00	4.930x104 4.750x104 4.55004 4.330x104 4.052x104 3.981x104 3.813x104 3.765x104 3.689 x104	3.689 x104
4		•		4.061x10°	4.061x104, 3.850x104; 3.6784		3.495×104		3,210×104	3.210x1043.080x104		
5	ا سعد خ			1.234×10	, 1.190×10	1.140	1.084x10	1.014x104	0.996x10	0.956×10	1.234×104" 1.190×104" 1.140 1.084×104 1.014×104 0.996×104 0.956×104 0.942×104 0.920×104	0.920x104
											<u> </u>	

= resonance frequency of cavity
=shift in resonance in frequency on introduction of the sample
= volume of cavity
= volume of sample
1.088c² 

c= velocity of light , d= diameter of eavity £2 42

Table II Surnery of E'/& for Lead Azide

	45.90   46.90   47.90   48.60		8 9.80 9.44	8 13.91 14.91	2	5 14.88 15.24
	5.97 06		9•71 9•58	86 12.98	00 16.42	66 14.25
- £0		··································	9.45	12•19 12•86	15.00	11.91 12.66
Frequency (Knc) - fo	41.40 1.42.20 1.44.90 E/E	6•28	7.59	11.99	13.46	11.17
Frequen	41.40	7.•07	9•40	10.83	12.52	11•33
	. 40•30	6.85	8*99	12.86	11.90	11.05
	39•46	09•9	8,97	11.39	11.83	17.07
e de la companya de l		ರ	യ	ପ	හු	δ-
Serre	Number	Н	ત્ય	m	7	

TABLE III

Summary of Observed Data for Calculation of  $\ensuremath{\mathcal{L}}_{c}$  of Polystyrene

Sample	Weight					Frequency (Kic)	(e)				
mber	of Sample (mg)		39.46	40.30	71.40	42.20 L	(,	45.90	06.97	47.90	9*87
1	0*3330	3.250x10 <sup>-4</sup>	27.7	29.5	31.4	33•0					
2	8 <b>1</b> £9•0	6 <b>.</b> 163 x10 <sup>-4</sup>	45.2	£*87	7*87						- Wil nip dia Vindiga
9	0.4398	4.219 x10 <sup>-4</sup>	31.0	31.6	31.6	7.98			ann day day day day		
7	0.3858	3.764 x10°4	31.2	31.0	32.0	35.1					
5	0,2168	2,115 x10 <sup>-4</sup>	18.5	17.5	18,3	د محمد بین ای					
9	0601.0	1.06 x10 <sup>-4</sup>		ند ند بر د د د د			24.9	24.2	24.6	27.0	24.7
2	0,0946	0.922 x10 <sup>-4</sup>		40 aw uin ha est sie			24.0	24.0	27.8	28.0	28.2
80	2111ء	1.084 x10 <sup>-4</sup>					17.8	17.6	20.5		18.6
6	77LO"3	0.696 x10 <sup>-4</sup>					13.0	13.7	74.0	12.7	
	Ð	<b>^</b>	0.950	0.911	0*8*0	0,831	0.734	0,702	669*0	0,645	0.627
	Cavity	Cavity Volume	0.7697	0 1531	7,67,0	2					

TABLE IV Summary of  $\mathcal{L}_{\mathcal{L}_c}$  Values for Polystyrene

	·			<del>-</del> 7	т	<u></u> T	~	<u>m</u> [		
78.60						3.68	4.52	2.98		
06*47			1	ļ	1	3.95	4.45		3 <b>.</b> 08	
06*97						3.69	87•7	3.11	3.32	
45.90						3.68	4-11	2.91	3.32	
(Kr.c.)						3.74	4.05	2.94	3,19	
Frequency (	200	2,85		1.98	2,10					
F 07.12	1 1	2,71	1.95	1.90	2°°2					
05-07		2.68	1.97	1.84	2.03					
30 14	77.40	2,60	2,23	2,30	2.39					
	Number	1	2	3	7	70	9	7	₩	6

TABLE V., Summary of Data on

3 <u>1</u> e	Type			Freque	Frequency (Knc) -fo	0				
Number	Crystal	39.46	1.40~30	62,040	1,2,20	06*77	1,45.90	146.90	147.90	09*87
<b>:</b> :				7) থু	ኤ(ፌፌ) по					
_	ರ	9*7	7.0	5,8	5.8					
2	ഹ	1.0	1.2	6.0	0.8	1,1	1.0	1.0	1.1	1.1
-	8	0.3	0.3	0,2	0.2	<b>b.</b> 3	0.2	6.0	2.0	0.3
	ന.	7.0	0.3	0.5	6.5		0.3	0,3		
-	8	1.3	1,3	1.0	1,2	1.0	1.3	1.2	1.2	1.0
1	***************************************	0.950		0,840	0.831	5.734	0,702	0.673	579.0	0.627
GF, -	1	37.49x 10	36,61×109	34.78x107	34.78×107 35.07×107	33.90×109	32.55×107	31.56x107	50.99×107	30.47×10
-	ឌ	เน	10-7 0.4627x10-7	0.4669x10-1	0.4403xJC=					
2	8		3.515×10-7	3.630x10-7	3.445x10-7 B	3.312×10-7	3.315×10-7	3.276×10-79.288×10-	9.288×10	3.282×10-
<u> </u>	8	13.15×10-7	12.97×10-7		12.93x10-7	2.23x10-7	12.23x10-12.10x10-1	12.10x10-7	12.15x10-7	12.11×10-
7	œ	10.83x10-7	10.51×10-7	10.57×10-7	9.965x10-7		9.862×10-7	9.759x10-		
1,50	æ	3.294×10-7	3.251×10-7	3.277x10-7	$3.094 \times 10^{-1} B.061 \times 10^{-1} / 3.060 \times 10^{-1} 3.029 \times 10^{-1} B.040 \times 10^{-1} / 3.029 \times 10^{-1}$	3.061×10-7	3.060×10-7	3.029×10	/_01x070-8/	13.029×10-
:	:				e/e,			·		
1	ಶ	0,220	0,185	0,249	0.255					
8	<b>6</b> 0).	0.356	0.422	196.0	0.276	0.364	0,332	0,328	D.362	0.361
8	8	0.395	0,380	0.262	0.258		0.245	0.363	D.243	0.363
1	ω.	0,433	0.305	0,528	867°0		0.296	0.283		
Ļ	0	7 700	100	À 20¢	17.27	אטיג	200	0 363		

\*\(\lambde{A}\) = \(\Delta\)F = \(\Delta\)F

IV. ERRORS

The expression for the real dieloctric constant,  $\mathcal{L}_{\epsilon}$ , is

$$\mathcal{L}_{c} = 1 + \frac{\Delta f}{f_{0}G}, \quad V_{c} / V_{g}$$
 (1)

where  $f_0$  is the resonance frequency of the cavity, Af is the shift in resonance frequency of the cavity on introduction of the sample  $V_c$  and  $V_g$  are the volumes of the cavity and the sample, respectively, and G is given by

$$G = \frac{1.008 \text{ s}^2}{\text{fo}^2 \text{ d}^2} \tag{2}$$

Here c is the velocity of light, d is the diameter of the cavity, and fo has been defined above.

The quantity Af is read directly from a General Radio Cacillator as described in an earlier report. Frequency calibration of this instrument indicates that it is accurate to 1%. However the blank spaces in the power versus frequency plot on the oscilloscope screen which serve as markers have a length which is dependent on the amplification in their four-channel amplifier. These factors, along with fluctuation of frequency along the frequency-axis of the oscilloscope, increase the error to about 2-2.5%. A typical series of Af values are those for sample number 2 lead axide. They are 21.5, 22.2, 22.2, 23.0, 23.0, 22.5, 22.7, 22.0, 22.2 and 22.2 mc with an average value of 22.4 mc. This range of ± 0.5 mc. corresponds to ± 0.2 units of about 2% assuming all other errors are negligible.

<sup>1.</sup> E. F. Labuda and R. C. LeCraw, Rev. Sci. Instruments 32, 391(1961).

<sup>2.</sup> Calibration performed by the General Radio Company.

The quantity  $f_0$  is easily read to 0.01 kmc which gives 1 part in 4000 in the 40 kmc region and above. But this is a wave meter reading and is dependent on the Q of the wavemeter cavity. This effect reduces the containty of  $f_0$  to about 1 in 400 based on the span of the frequency-axis of the oscilloscope.

The size of the cavity is sufficiently large to make the error in its volume small also. Since  $V_c$  is given by  $\pi r^2 l$ , where r is the radius and the length, its error can be calculated exactly.

$$\Delta V_{c} = 2 \pi r \Delta r + \pi r^{2} \Delta r \qquad (3)$$

where  $\Delta V_c$ , Ar and  $\Delta V_c$  are the errors in the values, radius and length of the cavity, respectively. The cavity was machined such that the error in r and  $\Delta V_c$  is about  $10^{-3}$  cm for each. With order of magnitudes of r and  $\Delta V_c$  of 0.5 cm and 1.0 cm, respectively,  $\Delta V_c = \Delta \times 10^{-3} \text{ cm}^3$ . Since  $V_c$  is about 0.5 cm<sup>3</sup>, the error in  $V_c$  is about 0.5%.

The error in  $V_s$ , the volume of the sample is not easily ostimated. In the milligram range the weight of the samples can be determined to a microgram. This would easily yield about 1 part in 1000 but the density is not known as well. More will be said about this problem below. For the present the error in  $V_s$  will be assumed to be of the same order us that in  $V_s$ . Thus it appears that the error in  $\Delta f$  at 2.5% is the largest single error factor and we expect on this basis that the error in  $\Delta f$  to be approximately  $\pm 3\%$ .

#### V. DISCUSSION

The data on  $\beta$ . -lead axide, while limited, tend to confirm our conclusion of the error in this method. This is also true when measurements on the same sample of  $\beta$ -lead axide are considered.

However, when different samples of  $\beta$  -load anide are compared at the same frequency, the agreement is poor, ranging from about 9-12 at 39 kmc and about 10-15 at 49 kmc. Such Muctuations in  $\frac{2}{6}$  are clearly outside the range of experimental error.

As stated earlier a study of several samples at the same frequency affords an opportunity to evaluate the effect of irregularities in the shape of the sample. While the crystals studied appear to be very small parallelepipeds when examined with the naked eye, with the aid of a microscope the faces are observed to be somewhat irregular. This means that instead of dealing with a single crystal, we have a large number of micro-crystals. It may be that the dielectric constant taken along different axes is different, that is to say it may be a tensor instead of a scalar. If this were true, clearly, crientation would greatly affect the values of the observed. Nethods to detect this by using a preferred orientation have not been attempted because of the very small size and fragility of these crystals. A tenth of a milligram crystal which is about 4 mm long is not easily oriented, although nethods could be devised.

When viewed under a microscope, it is evident that these crystals have many faults and defects. These make one suspicious of the use of the density as determined by x-ray diffraction. It is realized that the use of sample veluess calculated in this manner may

produce fluctuation in but no other method for determination of densities of those small crystals has been found in the literature or devised by us.

Another factor which should be considered is the fact that the sample increasingly reaches beyond the nodes in the field as the frequency is increased. Although the ends of the sample were positioned at nodes for the lowest frequency, this is true only at that frequency. This effect may be reflected in the increase in the increasing frequency, although it is more likely to have the opposite effect.

It has been observed that these small crystals will pick up (what has been interpreted as) free surface charges. The effect of this phenomenon, if any, in the experimental results is not known.

Finally, we point out that the rise in with frequency may be a response similar to that predicted by the results of classical electromagnetic theory. On the other hand it could preface the resonance one would expect if the azide ion has a ground state.

<sup>3.</sup> See for example: "Dielectric Materials and Applications", John Wiley and Sons, Inc.

<sup>4.</sup> M. Mizushima, Second Quarterly Report, October, 1958-January, 1959, Project Morty, ERDL, Fort Belvoir, Virginia.

### VI. PRESENT STATUS

At the present time we are determining to for lead azide in the 50-60 kmc range. Since the Polarad EHF power scurce does not come equipped with "plug-in" units above 50 kmc, it was necessary to design a "durmy" panel and alter the circuit such that beam voltage, reflector voltage, grid voltage, modulation, etc., could be controlled from this panel. In this way we are able to operate a klystron of any frequency range with this supply unit. This is not the most efficient unit however. Frequent interruptions are caused by malfunctioning. The problem has recently been solved by the purchase of an FXR Universal klystron supply. This was thought advisable since the klystron power supply presently being used in the microwave spectrograph does not belong to this project.

Recently, the two matched klystrons (QK-295), which together cover the 50-60 Kmc range, have been giving trouble. They have been returned to the Raytheon Company and as yet no word has been received concorning them. This has forced us to attempt to generate power in this range by using a lower-range klystron coupled to a harmonic multiplier. The frequency of this klystren is such that the second harmonic would cover a large portion of the 50-60 Kmc range. So far we have not been able to detect the second harmonic.

As soon as microwave power is available, the 50-60 Kmc range can be rapidly studied, barring any other serious malfunctioning. Indeed the waveguide circuit is complete up through the 75 Kmc point except for a wavity and the necessary klystrons.